Measurement Report for Device, FRONT, D2450, UID 0 -, Channel 50 (2450.0MHz)

Device under Test Properties

 Model, Manufacturer
 Dimensions [mm]
 IMEI
 DUT Type

 Device,
 100.0 x 20.0 x 10.0
 Phone

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|-------------------------|------------------------------|-------|---------------|------------------------------------|-------------------|------------------------|------------------|
| Flat, | FRONT, | D2450 | CW, | 2450.0, | 8.18 | 1.83 | 39.6 |
| HSI | 0.00 | | 0 | 50 | | | |

Hardware Setup

| Phantom | TSL, Measured Date | | | Probe, Calibration Date | DAE, Calibration Date |
|------------------------------------|-----------------------------|---------|-------|-----------------------------|-------------------------|
| ELI V8.0 (20deg probe tilt) - 2178 | HSL600-10000 2022-Aug-30 | Charge: | xxxx, | EX3DV4 - SN7733, 2022-08-02 | DAE4 Sn1739, 2022-07-29 |

Scan Setup

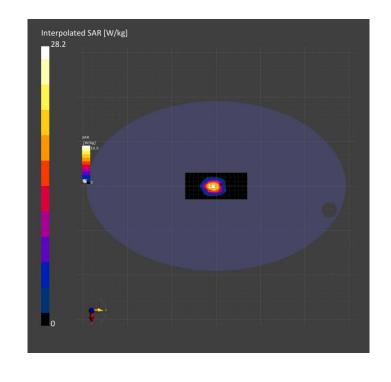
| - | Area Scan | Zoom Scan |
|---------------------|--------------|--------------------|
| Grid Extents [mm] | 60.0 x 140.0 | 30.0 x 30.0 x 30.0 |
| Grid Steps [mm] | 10.0 x 10.0 | 5.0 x 5.0 x 1.5 |
| Sensor Surface [mm] | 3.0 | 1.4 |
| Graded Grid | Yes | Yes |
| Grading Ratio | 1.5 | 1.5 |
| MAIA | N/A | N/A |
| Surface Detection | VMS + 6p | All points |
| Scan Method | Measured | Measured |
| | | |

Measurement Results

| | Area Scan | Zoom Scan |
|---------------------|-------------------|-------------------|
| Date | 2022-08-31, 10:02 | 2022-08-31, 10:16 |
| psSAR1g [W/kg] | 9.37 | 13.9 |
| psSAR10g [W/kg] | 4.51 | 6.52 |
| Power Drift [dB] | 0.01 | 0.01 |
| Power Scaling | Disabled | Disabled |
| Scaling Factor [dB] | | |
| TSL Correction | No correction | No correction |
| M2/M1 [%] | | 80.6 |
| Dist 3dB Peak [mm] | | 9.0 |

Warning(s) / Error(s)

Details Area Scan Zoom Scan



Measurement Report for Device, FRONT, D5GHz, UID 0 -, Channel 25 (5250.0MHz)

Device under Test Properties

 Model, Manufacturer
 Dimensions [mm]
 IMEI
 DUT Type

 Device,
 100.0 x 20.0 x 10.0
 Phone

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|-------------------------|------------------------------|-------|---------------|------------------------------------|-------------------|------------------------|------------------|
| Flat, | FRONT, | D5GHz | CW, | 5250.0, | 5.92 | 4.72 | 36.5 |
| HSI | 5.00 | | 0 | 25 | | | |

Hardware Setup

| Phantom | TSL, Measured Date | | | Probe, Calibration Date | DAE, Calibration Date |
|------------------------------------|-----------------------------|---------|-------|-----------------------------|-------------------------|
| ELI V8.0 (20deg probe tilt) - 2178 | HSL600-10000 2022-Aug-30 | Charge: | xxxx, | EX3DV4 - SN7733, 2022-08-02 | DAE4 Sn1739, 2022-07-29 |

Scan Setup

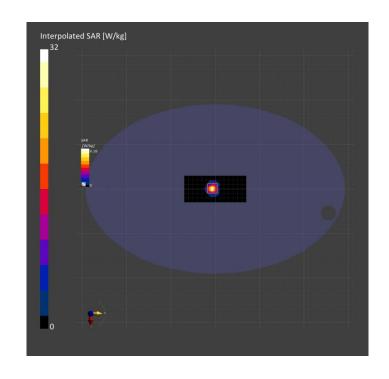
| | Area Scan | Zoom Scan |
|---------------------|--------------|--------------------|
| Grid Extents [mm] | 60.0 x 140.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm] | 10.0 x 10.0 | 4.0 x 4.0 x 1.4 |
| Sensor Surface [mm] | 3.0 | 1.4 |
| Graded Grid | Yes | Yes |
| Grading Ratio | 1.5 | 1.4 |
| MAIA | N/A | N/A |
| Surface Detection | VMS + 6p | VMS + 6p |
| Scan Method | Measured | Measured |
| | | |

Measurement Results

| | Area Scan | Zoom Scan |
|---------------------|-------------------|-------------------|
| Date | 2022-09-01, 11:28 | 2022-09-01, 11:36 |
| psSAR1g [W/kg] | 7.55 | 8.20 |
| psSAR10g [W/kg] | 2.31 | 2.36 |
| Power Drift [dB] | 0.00 | 0.00 |
| Power Scaling | Disabled | Disabled |
| Scaling Factor [dB] | | |
| TSL Correction | No correction | No correction |
| M2/M1 [%] | | 64.7 |
| Dist 3dB Peak [mm] | | 7.2 |

Warning(s) / Error(s)

Details Area Scan Zoom Scan



Measurement Report for Device, FRONT, D5GHz, UID 0 -, Channel 60 (5600.0MHz)

Device under Test Properties

| Model, Manufacturer | Dimensions [mm] | IMEI | DUT Type |
|---------------------|---------------------|------|-----------------|
| Device, | 100.0 x 20.0 x 10.0 | | Phone |

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|-------------------------|------------------------------|-------|---------------|------------------------------------|-------------------|------------------------|------------------|
| Flat, | FRONT, | D5GHz | CW, | 5600.0, | 5.08 | 4.95 | 36.0 |
| HSI | 0.00 | | 0 | 60 | | | |

Hardware Setup

| Phantom | TSL, Measured Date | | | Probe, Calibration Date | DAE, Calibration Date |
|------------------------------------|-----------------------------|---------|-------|-----------------------------|-------------------------|
| ELI V8.0 (20deg probe tilt) - 2178 | HSL600-10000 2022-Aug-30 | Charge: | xxxx, | EX3DV4 - SN7733, 2022-08-02 | DAE4 Sn1739, 2022-07-29 |

Scan Setup

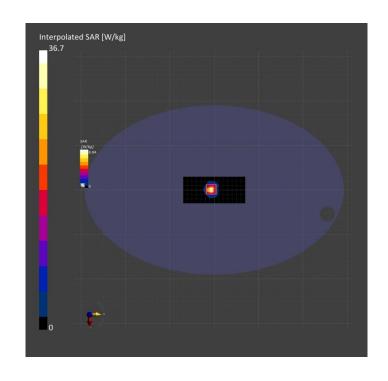
| | Area Scan | Zoom Scan |
|---------------------|--------------|--------------------|
| Grid Extents [mm] | 60.0 x 140.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm] | 10.0 x 10.0 | 4.0 x 4.0 x 1.4 |
| Sensor Surface [mm] | 3.0 | 1.4 |
| Graded Grid | Yes | Yes |
| Grading Ratio | 1.5 | 1.4 |
| MAIA | N/A | N/A |
| Surface Detection | VMS + 6p | VMS + 6p |
| Scan Method | Measured | Measured |

Measurement Results

| | Area Scan | Zoom Scan |
|---------------------|-------------------|-------------------|
| Date | 2022-09-01, 13:08 | 2022-09-01, 13:16 |
| psSAR1g [W/kg] | 7.98 | 8.70 |
| psSAR10g [W/kg] | 2.38 | 2.48 |
| Power Drift [dB] | 0.01 | -0.00 |
| Power Scaling | Disabled | Disabled |
| Scaling Factor [dB] | | |
| TSL Correction | No correction | No correction |
| M2/M1 [%] | | 61.9 |
| Dist 3dB Peak [mm] | | 7.2 |

Warning(s) / Error(s)

Details Area Scan Zoom Scan



Measurement Report for Device, FRONT, D5GHz, UID 0 -, Channel 75 (5750.0MHz)

Device under Test Properties

 Model, Manufacturer
 Dimensions [mm]
 IMEI
 DUT Type

 Device,
 100.0 x 20.0 x 10.0
 Phone

Exposure Conditions

| Phantom Section, TSL | Position, Test Distance [mm] | Band | Group, UID | Frequency [MHz], Channel Number | Conversion Factor | TSL Conductivity [S/m] | TSL Permittivity |
|-------------------------|---------------------------------|-------|---------------|------------------------------------|-------------------|------------------------|------------------|
| Flat, | FRONT, | D5GHz | CW, | 5750.0, | 5.15 | 5.16 | 36.1 |
| ПСI | 0.00 | | 0 | 75 | | | |

Hardware Setup

| Phantom | TSL, Measured Date | | | Probe, Calibration Date | DAE, Calibration Date |
|------------------------------------|--------------------|---------|-------|-----------------------------|-------------------------|
| ELI V8.0 (20deg probe tilt) - 2178 | HSL600-10000 | Charge: | xxxx, | EX3DV4 - SN7733, 2022-08-02 | DAE4 Sn1739, 2022-07-29 |
| | 2022-Aug-30 | | | | |

Scan Setup

| | Area Scan | Zoom Scan |
|---------------------|--------------|--------------------|
| Grid Extents [mm] | 60.0 x 140.0 | 22.0 x 22.0 x 22.0 |
| Grid Steps [mm] | 10.0 x 10.0 | 4.0 x 4.0 x 1.4 |
| Sensor Surface [mm] | 3.0 | 1.4 |
| Graded Grid | Yes | Yes |
| Grading Ratio | 1.5 | 1.4 |
| MAIA | N/A | N/A |
| Surface Detection | VMS + 6p | VMS + 6p |
| Scan Method | Measured | Measured |

Measurement Results

| | Area Scan | Zoom Scan |
|---------------------|-------------------|-------------------|
| Date | 2022-09-01, 14:19 | 2022-09-01, 14:27 |
| psSAR1g [W/kg] | 6.76 | 7.53 |
| psSAR10g [W/kg] | 2.05 | 2.15 |
| Power Drift [dB] | -0.00 | -0.03 |
| Power Scaling | Disabled | Disabled |
| Scaling Factor [dB] | | |
| TSL Correction | No correction | No correction |
| M2/M1 [%] | | 60.5 |
| Dist 3dB Peak [mm] | | 7.2 |

Warning(s) / Error(s)

Details Area Scan Zoom Scan

